

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant :	Marcus Dill, et al.	Art Unit :	2171
Serial No. :	10/816,910	Examiner :	Unknown
Filed :	April 5, 2004	Confirmation No.:	2649
Title :	PERFORMING A DATA ANALYSIS PROCESS		

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

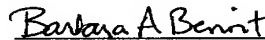
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed before the receipt of a first Office Action on the merits. No charge is believed due at this time. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: February 9, 2006


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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13906-126001	Application No. 10/816,910
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Marcus Dill, et al.	
		Filing Date April 5, 2004	Group Art Unit 2171

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	2002/0133490	09/19/2002	Conkwright,			12/18/2001
	AB	2004/0002961	01/01/2004	Dettinger,			06/27/2002
	AC	2004/0215501	10/28/2004	d'Ornano			04/24/2003
	AD	6,473,757	10/29/2002	Garofalakis			03/28/2000
	AE	6,636,860	10/21/2003	Vishnubhotla			04/26/2001
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	